CDCV857A 2.5-V PHASE LOCK LOOP CLOCK DRIVER

SCAS667A - APRIL 2001 - REVISED AUGUST 2002

- **Phase-Lock Loop Clock Driver for Double Data-Rate Synchronous DRAM Applications**
- **Spread Spectrum Clock Compatible**
- Operating Frequency: 60 to 180 MHz
- Low Jitter (cyc-cyc): ±50 ps
- **Distributes One Differential Clock Input to Ten Differential Outputs**
- Three-State Outputs When the Input Differential Clocks Are <20 MHz
- **Operates From Dual 2.5-V Supplies**
- Available in a 48-Pin TSSOP Package or 56-Ball MicroStar Junior™ BGA Package
- Consumes < 200-µA Quiescent Current
- External Feedback PIN (FBIN, FBIN) Are Used to Synchronize the Outputs to the **Input Clocks**

description

The CDCV857A is a high-performance, low-skew, low-jitter zero delay buffer that distributes a differential clock input pair (CLK, $\overline{\text{CLK}}$) to ten differential pairs of clock outputs (Y[0:9], $\overline{\text{Y[0:9]}}$) and one differential pair of feedback clock output (FBOUT, FBOUT). The clock outputs are controlled by the clock inputs (CLK, CLK), the feedback clocks (FBIN, FBIN), and the analog power input (AVDD). When PWRDWN is high, the outputs switch in phase and frequency with CLK. When PWRDWN is low, all outputs are disabled to high impedance state (3-state), and the PLL is shut down (low power mode). The device also enters this low power mode when the input frequency falls below a suggested detection frequency that is below 20 MHz (typical 10 MHz). An input frequency detection circuit will detect the low frequency condition and after applying a >20 MHz input signal this detection circuit turns on the PLL again and enables the outputs.

When AV_{DD} is strapped low, the PLL is turned off and bypassed for test purposes. The CDCV857A is also able to track spread spectrum clocking for reduced EMI.

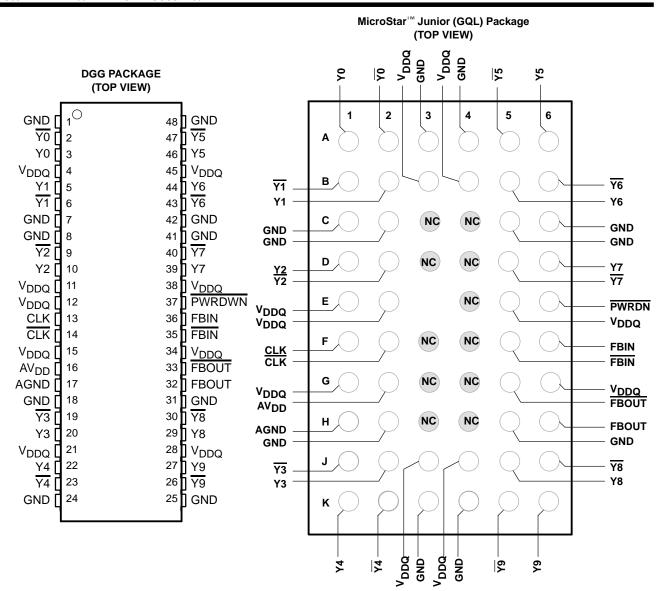
Since the CDCV857A is based on PLL circuitry, it requires a stabilization time to achieve phase-lock of the PLL. This stabilization time is required following power up. The CDCV857A is characterized for operation from 0°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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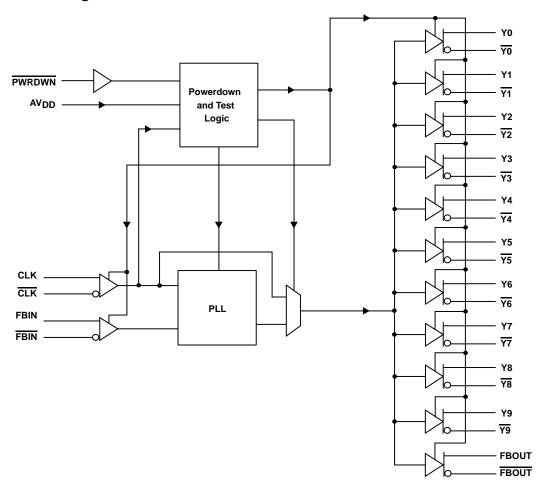




FUNCTION TABLE (Select Functions)

	INPUTS	3			OU.		PLL	
AV _{DD}	PWRDWN	CLK	CLK	Y[0:9]	Y[0:9]	FBOUT	FBOUT	
GND	Н	L	Н	L	Н	L	Н	Bypassed/Off
GND	Н	Н	L	Н	L	Н	L	Bypassed/Off
Х	L	L	Н	Z	Z	Z	Z	Off
Х	L	Н	L	Z	Z	Z	Z	Off
2.5 V (nom)	Н	L	Н	L	Н	L	Н	On
2.5 V (nom)	Н	Н	Ĺ	Н	Ĺ	Н	Ĺ	On
2.5 V (nom)	Х	<20 MHz	<20 MHz	Z	Z	Z	Z	Off

functional block diagram



Terminal Functions

Т	ERMINAL			DESCRIPTION
NAME	DGG	GQL		DESCRIPTION
AGND	17	H1		Ground for 2.5-V analog supply
AV_{DD}	16	G2		2.5-V Analog supply
CLK, CLK	13, 14	F1, F2	I	Differential clock input
FBIN, FBIN	35, 36	F5, F6	Ι	Feedback differential clock input
FBOUT, FBOUT	32, 33	H6, G5	0	Feedback differential clock output
GND	1, 7, 8, 18, 24, 25, 31, 41, 42, 48	A3, A4, C1, C2, C5, C6, H2, H5, K3, K4		Ground
PWRDWN	37	E6	1	Output enable for Y and \overline{Y}
VDDQ	4, 11, 12, 15, 21, 28, 34, 38, 45	B3, B4, E1, E2, E5, G1, G6, J3, J4		2.5-V Supply
Y[0:9]	3, 5, 10, 20, 22, 27, 29, 39, 44, 46	A1, B2, D1, J2, K1, A6, B5, D6, J5, K6	0	Buffered output copies of input clock, CLK
<u>Y[0:9]</u>	2, 6, 9, 19, 23, 26, 30, 40, 43, 47	A2, B1, D2, J1, K2, A5, B6, D5, J6, K5	0	Buffered output copies of input clock, CLK

absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{DDQ} , AV _{DD}	0.5 V to 3.6 V
Input voltage range, V _I (see Notes 1 and 2)	0.5 V to V _{DDQ} 0.5 V
Output voltage range, V _O (see Notes 1 and 2)	–0.5 V to V _{DDQ} 0.5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{DDQ}$)	±50 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{DDQ}$)	±50 mA
Continuous output current, I _O (V _O = 0 to V _{DDQ})	±50 mA
Continuous current to GND or V _{DDQ}	±100 mA
Package thermal impedance, θ _{JA} (see Note 3): DGG package	89°C/W
GQL package	137.6°C/W
Storage temperature range T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 3.6 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.



CDCV857A 2.5-V PHASE LOCK LOOP CLOCK DRIVER

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recommended operating conditions (see Note 4)

			MIN	TYP	MAX	UNIT	
Supply voltage, V _{DDQ} , AV _{DD}			2.3		2.7	V	
Law layed input valtage Mr.		CLK, FBIN, FBIN			V _{DDQ} /2 – 0.18	V	
Low level input voltage, V _{IL}	PWR	DWN	-0.3		0.7	V	
High level input voltage, V _{IH}	CLK,	CLK, FBIN, FBIN	V _{DDQ} /2 + 0.18			V	
Trigit level input voltage, vIH	PWR	DWN	1.7		V _{DDQ} + 0.3	V	
DC input signal voltage (see Note 5)			-0.3		V_{DDQ}	V	
Differential input signal voltage, VID (see Note 6)	DC	CLK, FBIN	0.36		V _{DDQ} + 0.6	٧	
Differential input signal voltage, VID (see Note 0)	AC	CLK, FBIN	0.7		V _{DDQ} + 0.6		
Output differential cross-voltage, VOX (see Note 7)			V _{DDQ} /2 – 0.2	V _{DDQ} /2	$V_{DDQ}/2 + 0.2$	V	
Input differential pair cross-voltage, V _{IX} (see Note 7)			V _{DDQ} /2 – 0.2		$V_{DDQ}/2 + 0.2$	V	
High-level output current, IOH					-12	mA	
Low-level output current, IOL			12	mA			
Input slew rate, SR			1		4	V/ns	
Operating free-air temperature, T _A			0		85	°C	

NOTES: 4. Unused inputs must be held high or low to prevent them from floating.

- 5. DC input signal voltage specifies the allowable dc execution of differential input.
- 6. Differential input signal voltage specifies the differential voltage |VTR VCP| required for switching, where VTR is the true input level and VCP is the complementary input level.
- 7. Differential cross-point voltage is expected to track variations of VCC and is the voltage at which the differential signals must be crossing.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST Co	ONDITIONS	MIN	TYP†	MAX	UNIT
VIK	Input voltage	All inputs	$V_{DDQ} = 2.3 V,$	I _I = -18 mA			-1.2	V
V	High lovel outp	ıt voltogo	V _{DDQ} = min to max	x, I _{OH} = −1 mA	V _{DDQ} - 0.1			V
VOH	High-level output voltage		$V_{DDQ} = 2.3 V,$	I _{OH} = -12 mA	1.7			V
V 0 1	VOI Low-level output voltage		V _{DDQ} = min to max			0.1	V	
VOL	Low-level outpu	ii voitage	$V_{DDQ} = 2.3 V,$	V _{DDQ} = 2.3 V, I _{OL} = 12 mA			0.6	V
IOH	High-level outp	ut current	$V_{DDQ} = 2.3 V,$	V _O = 1 V	-18	-32		mA
IOL	Low-level outpu	it current	$V_{DDQ} = 2.3 V,$	V _O = 1.2 V	26	35		mA
٧o	Output voltage	swing	Differential outputs	are terminated with	1.1		V _{DDQ} - 0.4	
Vox	Output different cross-voltage§	ial	120 Ω)ifferential outputs are terminated with $20\;\Omega$		V _{DDQ} /2	V _{DDQ} /2 + 0.2	V
lį	Input current		$V_{DDQ} = 2.7 V,$	V _I = 0 V to 2.7 V			±10	μА
loz	High-impedanc output current	e-state	$V_{DDQ} = 2.7 \text{ V}, \qquad V_{Q} = V_{DDQ} \text{ or GND}$				±10	μΑ
I _{DDPD}	Power down cu V _{DDQ} + AV _{DD}	rrent on	CLK and $\overline{\text{CLK}} = 0 \text{ M}$ Σ of IDD and AIDD	IHz; PWRDWN = Low;		100	200	μΑ
			Differential outputs	f _O = 180 MHz		275	330	
	Dunamia aurran	ot on Vana	terminated with 120 Ω /CL = 14 pF	f _O = 167 MHz		250	300	mA
IDD	Dynamic currer	it on vDDQ	Differential outputs	f _O = 180 MHz		225	275	IIIA
			terminated with $120 \Omega/CL = 0 pF$	f _O = 167 MHz		210	250	
A1	Cumply augreent	an A\/	f _O = 180 MHz			10	12	-m A
AIDD	Supply current	OU AADD	f _O = 167 MHz			8	10	mA
Cl	Input capacitan	се	V _{CC} = 2.5 V	$V_I = V_{CC}$ or GND	2	2.5	3	pF
CO	Output capacita	ince	V _{CC} = 2.5 V	$V_O = V_{CC}$ or GND	2.5	3	3.5	pF

timing requirements over recommended ranges of supply voltage and operating free-air temperature

		MIN	MAX	UNIT
f =	Operating clock frequency	60	180	MHz
fCLK	Application clock frequency	60	100	IVITIZ
	Input clock duty cycle	40%	60%	
	Stabilization time¶ (PLL mode)		10	μs
	Stabilization time¶ (Bypass mode)		30	ns

[¶] Time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. For phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at CLK. Until phase lock is obtained, the specifications for propagation delay, skew, and jitter parameters given in the switching characteristics table are not applicable. This parameter does not apply for input modulation under SSC application.



 $[\]uparrow$ All typical values are at respective nominal V_{DDQ}. \uparrow The value of V_{OC} is expected to be |VTR + VCP|/2. In case of each clock directly terminated by a 120- Ω resistor, where VTR is the true input signal voltage and VCP is the complementary input signal voltage.

[§] Differential cross-point voltage is expected to track variations of VDDQ and is the voltage at which the differential signals must be crossing.

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switching characteristics

	PARAMETER	TES	ST CONDITIONS	MIN TY	P [†] MAX	UNIT	
[‡]	Low to high level propagation delay time	Test mod	e/CLK to any output		4.5	ns	
[‡] PHL	High-to low level propagation delay time	Test mod	e/CLK to any output		4.5	ns	
8	litter (period) Can Figure 6	66 MHz		-55	55	ps	
^t jit(per) [§]	Jitter (period), See Figure 6	100/133/	167/180 MHz	-35	35	ps	
δ	litter (evale to evale). See Figure 2	66 MHz		-60	60		
^t jit(cc) [§]	Jitter (cycle-to-cycle), See Figure 3	100/133/	167/180 MHz	-50	50	ps	
8 11 11 11 11 11 11		66 MHz		-100	100		
^t jit(hper) [§]	Half-period jitter, See Figure 7	100/133/	167/180 MHz	-75	75	ps 5	
t _{slr(i)}	Input clock slew rate, See Figure 8			1	4	V/ns	
tslr(o)	Output clock slew rate, See Figure 8			1	2	V/ns	
` ′		SSC off	66 MHz	-180	180	-	
			100/133 MHz	-130	130		
8	Dynamic phase offset (this includes jitter), See		167/180 MHz	-90	90	ps	
^t d(Ø) [§]	Figure 4(b)		66 MHz	-230	230		
		SSC on	100/133 MHz	-170	170		
			167/180 MHz	-100	100		
4	Station book offeet Con Figure 4/o)	66 MHz		-150	150		
^t (Ø)	Static phase offset, See Figure 4(a)	100/133/	167/180 MHz	-100	100	ps	
tsk _(o) ¶	Output skew, See Figure 5				75	ps	
tr, tf	Output rise and fall times (20% – 80%)) Ω/14 pF	650	900	ps	

[†] All typical values are at a respective nominal V_{DDQ}.
‡ Refers to transition of noninverting output.
§ This parameter is assured by design but can not be 100% production tested.
¶ All differential output pins are terminated with 120 Ω/14 pF.

PARAMETER MEASUREMENT INFORMATION

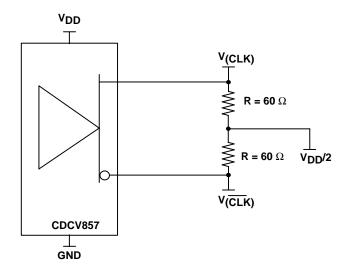
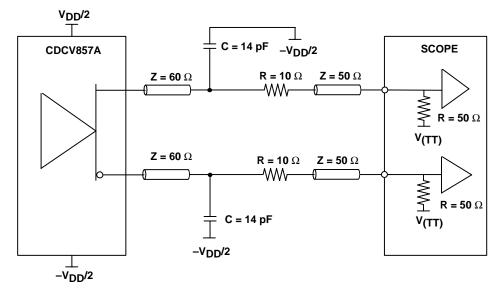


Figure 1. IBIS Model Output Load (used for slew rate measurement)



NOTE: V(TT)= GND

Figure 2. Output Load Test Circuit

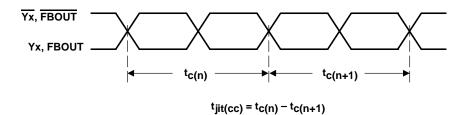
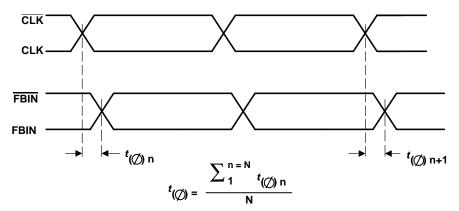


Figure 3. Cycle-to-Cycle Jitter

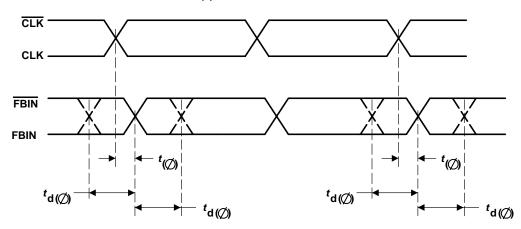


PARAMETER MEASUREMENT INFORMATION



(N is a large number of samples)

(a) Static Phase Offset



(b) Dynamic Phase Offset

Figure 4. Phase Offset

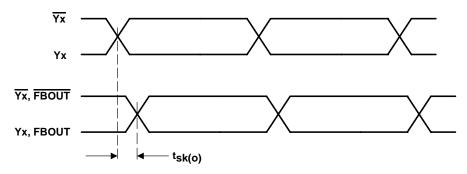


Figure 5. Output Skew

PARAMETER MEASUREMENT INFORMATION

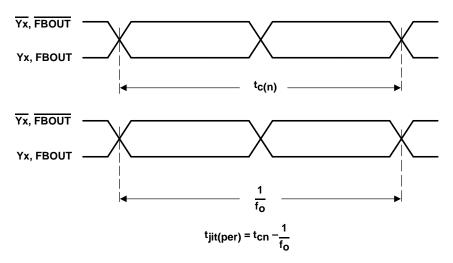
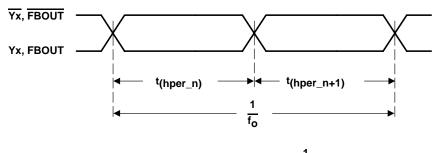


Figure 6. Period Jitter



 $t_{jit(hper)} = t_{(hper_n)} \frac{1}{2xf_0}$

Figure 7. Half-Period Jitter

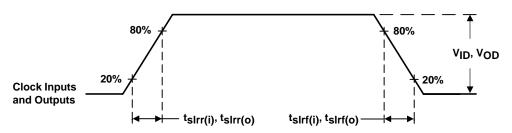


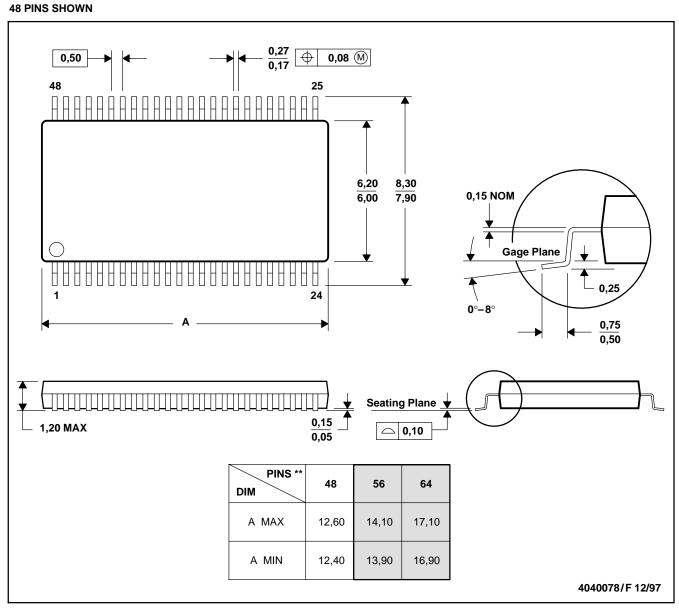
Figure 8. Input and Output Slew Rates

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MECHANICAL DATA

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

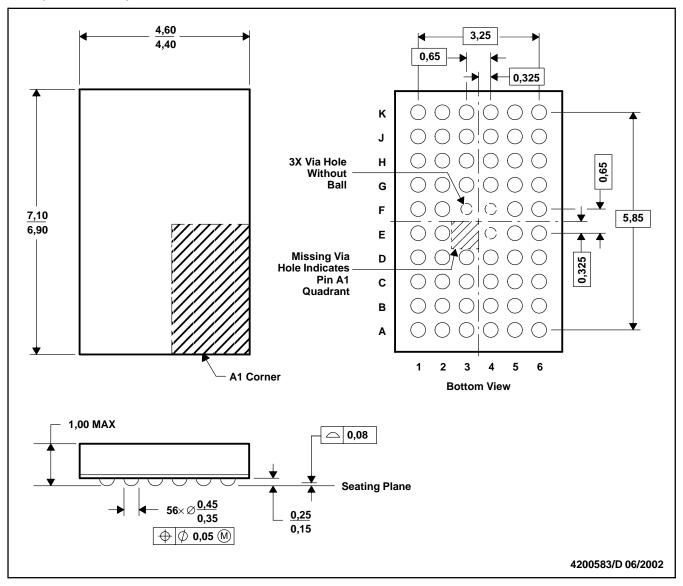
C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

MECHANICAL DATA

GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. MicroStar Junior™ BGA configuration
- D. Falls within JEDEC MO-225 variation BA.
- $E. \ \ \, \text{This package is tin-lead (SnPb)}. \ \, \text{Refer to the 56 ZQL package (drawing 4204437) for lead-free}.$

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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CDCV857ADGG	ACTIVE	TSSOP	DGG	48	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CDCV857ADGGG4	ACTIVE	TSSOP	DGG	48	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CDCV857ADGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CDCV857ADGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CDCV857AGQLR	ACTIVE	BGA MI CROSTA R JUNI OR	GQL	56	1000	TBD	SNPB	Level-2A-220C-4 WKS

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

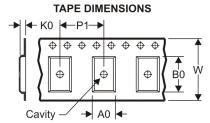
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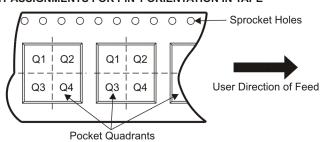
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
D1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCV857ADGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1
CDCV857AGQLR	BGA MI CROSTA R JUNI OR	GQL	56	1000	330.0	16.4	4.8	7.3	1.45	8.0	16.0	Q1





*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCV857ADGGR	TSSOP	DGG	48	2000	346.0	346.0	41.0
CDCV857AGQLR	BGA MICROSTAR JUNIOR	GQL	56	1000	346.0	346.0	33.0

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